

<b>Notice of References Cited</b>	Application/Control No. 10/587,592	Applicant(s)/Patent Under Reexamination MEGURO ET AL.	
	Examiner Brian K. Talbot	Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Lau et al. "Growth of epitaxial ZnO Thin Films by Organometallic Chemical Vapor Deposition" Journal of Electrochemical Society, Electrochemical Society. Manchester, News Hamshire, Vol. 127. No. 8, pp. 1843-1847, 1980 No month available
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